

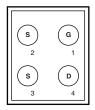


# P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>e</sup>	Q <sub>g</sub> (Typ.)				
- 20	0.084 at V <sub>GS</sub> = - 4.5 V	- 9.8					
	0.100 at V <sub>GS</sub> = - 2.5 V	- 9.0					
	0.120 at V <sub>GS</sub> = - 1.8 V	- 5.0	9.5 nC				
	0.155 at V <sub>GS</sub> = - 1.5 V	- 2.0					
	$0.495$ at $V_{GS} = -1.2 \text{ V}$	- 0.5					

### **MICRO FOOT**

Bump Side View



**Device Marking:** 8445 xxx = Date/Lot Traceability Code

Ordering Information: Si8445DB-T2-E1 (Lead (Pb)-free)

### **FEATURES**

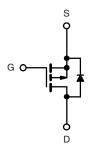
- TrenchFET<sup>®</sup> Power MOSFET
- Ultra Small 1.2 mm Length x 1 mm Width
- Ultra Thin 0.59 mm Height



ROHS

## **APPLICATIONS**

- Portable Devices
  - Battery Management
  - Low Threshold Load Switch
  - Battery Protection



P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 20	V		
Gate-Source Voltage		V <sub>GS</sub>	± 5	v	
	T <sub>C</sub> = 25 °C		- 9.8		
Continuous Proin Current /T 150 °C)	T <sub>C</sub> = 70 °C		- 7.9		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 3.9 <sup>a, b</sup>		
	T <sub>A</sub> = 70 °C		- 3.1 <sup>a, b</sup>	А	
Pulsed Drain Current	I <sub>DM</sub>	- 10			
0 " 0 5 5 1 0 1	T <sub>C</sub> = 25 °C	1	- 9.5		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 1.5 <sup>a, b</sup>		
	T <sub>C</sub> = 25 °C		11.4		
Manipular Davier Dissipation	T <sub>C</sub> = 70 °C	ь Г	7.3	10/	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.8 <sup>a, b</sup>	W	
	T <sub>A</sub> = 70 °C		1.1 <sup>a, b</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150			
Package Reflow Conditions <sup>c</sup>	IR/Convection		260	- °C	

# Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. t = 5 s.
- c. Refer to IPC/JEDEC (J-STD-020C), no manual or hand soldering.
- d. In this document, any reference to case represents the body of the MICRO FOOT device and foot is the bump.
- e. Based on  $T_C = 25$  °C.



THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>a, b</sup>	R <sub>thJA</sub>	55	70	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	8.5	11	7 0/**		

### Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. Maximum under Steady State conditions is 100  $^{\circ}\text{C/W}.$
- c. Case is defined as top surface of the package.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			•				
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS}$ = 0 V, $I_D$ = - 250 $\mu A$	- 20			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$\Delta V_{DS}/T_J$ $I_D = -250 \mu A$		- 19		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	1Β = - 250 μΑ		2.3		IIIV/ C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 0.35		- 0.85	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			± 100	nA	
Zava Cata Valtaga Drain Current	1	V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V	-1		- 1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$			- 10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 5			Α	
		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 1 A		0.070	0.084	Ω	
		V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 1 A		0.082	0.100		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 1.8 V, I <sub>D</sub> = - 1 A		0.097	0.120		
		$V_{GS} = -1.5 \text{ V}, I_D = -0.7 \text{ A}$		0.115	0.155		
		$V_{GS} = -1.2 \text{ V}, I_D = -0.2 \text{ A}$		0.165	0.495		
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 1 A		6.5		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			700			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		130		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			80		1	
Total Gate Charge	$Q_g$	$V_{DS} = -10 \text{ V}, V_{GS} = -5 \text{ V}, I_D = -1 \text{ A}$		10.5	16		
Total date onlarge				9.5	15	nC	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = 1 \text{ A}$		0.9			
Gate-Drain Charge	$Q_{gd}$			2.2			
Gate Resistance	$R_g$	$V_{GS} = -0.1 \text{ V, f} = 1 \text{ MHz}$		5.5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			11	20		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 10 $\Omega$		25	40	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 1 A, $V_{GEN}=$ - 4.5 V, $R_g=$ 1 $\Omega$		37	55		
Fall Time	t <sub>f</sub>			10	15		





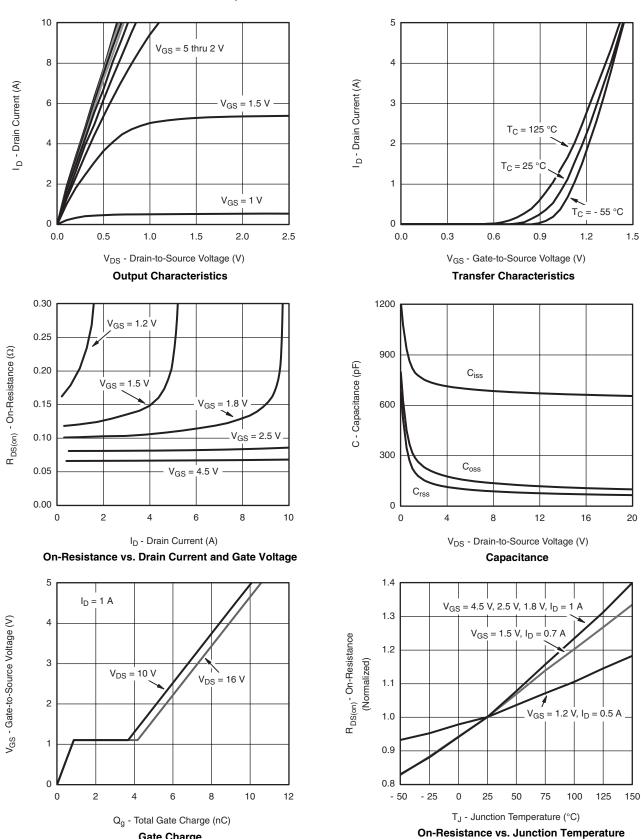
<b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Drain-Source Body Diode Characteristi	Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 9.5	Α		
Pulse Diode Forward Current	I <sub>SM</sub>				- 10			
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 1 A, V <sub>GS</sub> = 0 V		- 0.7	- 1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns		
Body Diode Reverse Recovery Charge	$Q_{rr}$	I <sub>F</sub> = - 1 A, dl/dt = 100 A/μs, T <sub>.1</sub> = 25 °C		10	20	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	1 - 1 A, απαι		9		ns		
Reverse Recovery Rise Time	t <sub>b</sub>			16		110		

#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

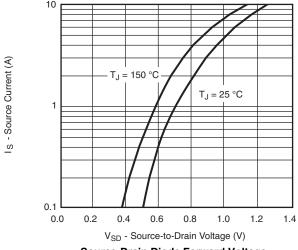
# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



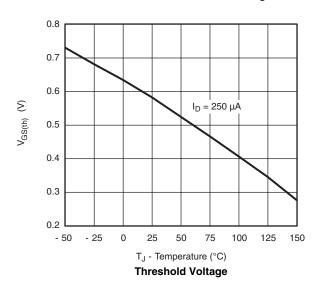
**Gate Charge** 

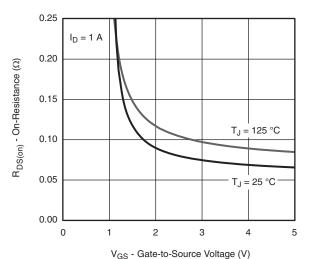


# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

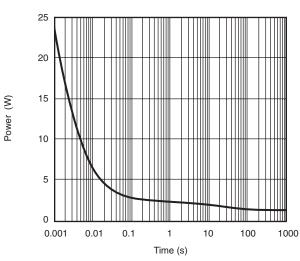


### Source-Drain Diode Forward Voltage

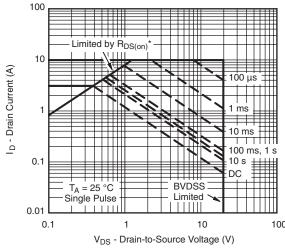




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

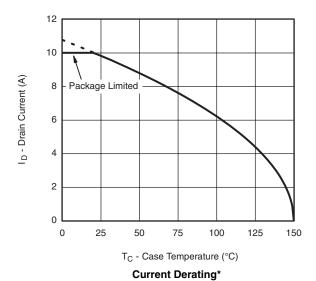


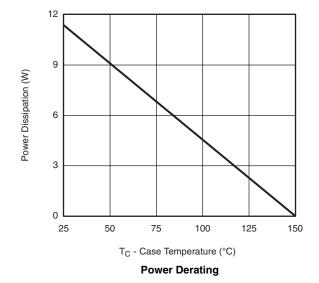
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

# VISHAY

# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

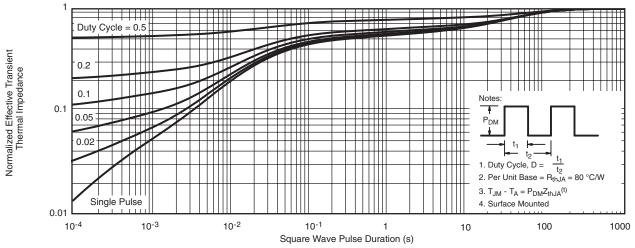




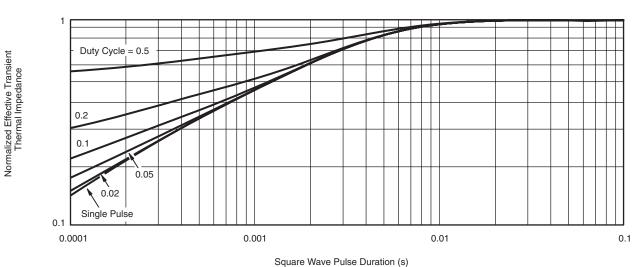
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### Normalized Thermal Transient Impedance, Junction-to-Ambient

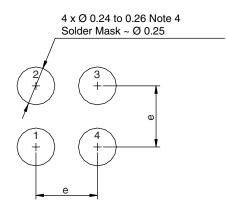


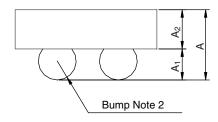
Normalized Thermal Transient Impedance, Junction-to-Foot

# VISHAY.

### **PACKAGE OUTLINE**

# MICRO FOOT: 4-BUMP (2 x 2, 0.5 mm PITCH)

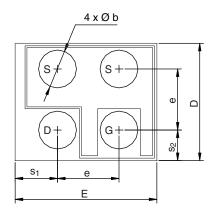




Recommended Land



Mark on Backside of die



Notes (Unless otherwise specified):

- 1. All dimensions are in millimeters.
- 2. Four (4) solder bumps are lead (Pb)-free 95.5Sn/3.8Ag/0.7Cu with diameter  $\varnothing$  0.30 to 0.32 mm.
- 3. Backside surface is coated with a Ti/Ni/Ag layer.
- 4. Non-solder mask defined copper landing pad.
- 5. is location of pin 1.

Dim.		Millimeters <sup>a</sup>		Inches			
	Min.	Nom.	Max.	Min.	Nom.	Max.	
Α	0.510	0.550	0.590	0.0201	0.0217	0.0232	
A <sub>1</sub>	0.220	0.250	0.280	0.0087	0.0098	0.0110	
A <sub>2</sub>	0.290	0.300	0.310	0.0114	0.0118	0.0122	
b	0.300	0.310	0.320	0.0118	0.0122	0.0126	
е	0.500			0.0197			
s <sub>1</sub>	0.330	0.340	0.350	0.0130	0.0134	0.0138	
s <sub>2</sub>	0.230	0.240	0.250	0.0090	0.0094	0.0098	
D	0.960	0.980	1.000	0.0378	0.0388	0.0394	
E	1.160	1.180	1.200	0.0457	0.0465	0.0472	

#### Notes:

a. Use millimeters as the primary measurement.

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